Search Notes

Application/Control	No
10/574,110	
Examiner	

Jennifer Y. Cho

Applicant(s)/Patent under Reexamination HAYASHI, TOSHIO Art Unit

SEARCHED					
Class	Subclass	Date	Examiner		
568	438	3/2/2007	1C		
560	103	3/5/07	sc		
560	510	3/5/07	1C		

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
East Search	3/2/2007	JC
Inventor Search	3/2/2007	JC
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